

## **Excellent Integrated System Limited**

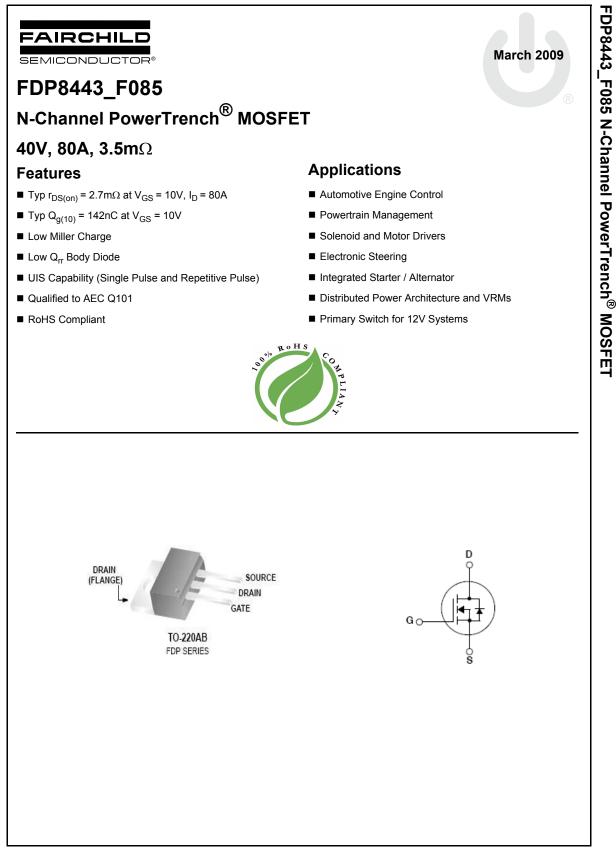
Stocking Distributor

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Fairchild Semiconductor FDP8443\_F085

For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>





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Symbol			Parame	ter					Rating	s	Units
/ <sub>DSS</sub>	Drain to S	ource Voltage							40		V
/ <sub>GS</sub>	Gate to Se	ource Voltage							±20		V
		rent Continuous (T <sub>0</sub>							80		
C	Continuou	is ( $T_{amb} = 25^{\circ}C, V_{GS}$	<sub>S</sub> = 10V, wit	h R <sub>θJA</sub> =	= 62 <sup>o</sup> C/W)				20		Α
	Pulsed							S	ee Figu	re 4	
AS	Single Pu	lse Avalanche Ener	gy			(Nc	ote 1)		531		mJ
D	Power Dis	sipation							188		W
	Derate ab								1.25		W/ºC
T <sub>J</sub> , T <sub>STG</sub>	Operating	and Storage Temp	erature					-	55 to +1	75	°C
[herm	al Cha	racteristics									
	1										
۲ <sub>θJC</sub>	Thermal F	Resistance Junction	to Case						0.8		°C/W
$R_{\theta JA}$	Thermal F	Resistance Junction	to Ambient	t		(No	te 2)		62		°C/W
Packa	ge Mar	king and Or	dering	Infor	mation						
Device	Marking	Device	Packa	ge	Reel Size	•	Тар	e Width		Quan	tity
FDF	P8443	FDP8443_F085	TO-220	AB	Tube			N/A		50 ur	nits
Symbol		Parameter			Test Condit			Min	Тур	Max	Units
Off Cha	racterist	ics									
Dff Cha B <sub>VDSS</sub>		ource Breakdown \	/oltage	I <sub>D</sub> = 25	60μΑ, V <sub>GS</sub> = 0V	/		40		-	V
B <sub>VDSS</sub>	Drain to S	ource Breakdown \		V <sub>DS</sub> =	32V,			40	-	- 1	
BVDSS	Drain to S			V <sub>DS</sub> = V <sub>GS</sub> =	32V, 0V	/ T <sub>C</sub> = 15	0°C	40 - -		- 1 250	V µA
B <sub>VDSS</sub> DSS	Drain to S Zero Gate	ource Breakdown \	rent	V <sub>DS</sub> =	32V, 0V		0°C	40 - - -	-	-	
BVDSS DSS GSS	Drain to S Zero Gate Gate to Se	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V <sub>DS</sub> = V <sub>GS</sub> =	32V, 0V		0°C	-	- - -	250	μA
B <sub>VDSS</sub> DSS GSS	Drain to S Zero Gate	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V <sub>DS</sub> = V <sub>GS</sub> =	32V, 0V		0°C	-	-	250	μA
B <sub>VDSS</sub> DSS GSS Dn Cha	Drain to S Zero Gate Gate to So racterist	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V <sub>DS</sub> = V <sub>GS</sub> = V <sub>GS</sub> =	32V, 0V	T <sub>C</sub> = 15	0°C	-	- - - 2.8	250	μA
B <sub>VDSS</sub> DSS GSS Dn Cha	Drain to S Zero Gate Gate to So racterist	ource Breakdown V Voltage Drain Curr purce Leakage Curr ics	rent	$V_{DS}$ = $V_{GS}$ = $V_{GS}$ =	32V, 0V ±20V	T <sub>C</sub> = 15	0°C	-		250 ±100	μA nA
B <sub>VDSS</sub> DSS GSS	Drain to S Zero Gate Gate to S racterist Gate to S	ource Breakdown V Voltage Drain Curr purce Leakage Curr ics	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T <sub>C</sub> = 15	0°C	2	2.8 2.7	250 ±100 4 3.5	μA nA
BVDSS DSS GSS Dn Cha / <sub>GS(th)</sub>	Drain to S Zero Gate Gate to S racterist Gate to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr <b>ics</b> ource Threshold Vo	rent rent Ditage	$V_{DS} =$ $V_{GS} =$ $V_{GS} =$ $V_{GS} =$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8	250 ±100	μA nA V
BVDSS DSS DSS Dn Cha /GS(th) DS(on)	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
B <sub>VDSS</sub> DSS GSS Dn Cha / <sub>GS(th)</sub> DS(on)	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr <b>ics</b> ource Threshold Vo	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
3 <sub>VDSS</sub> DSS GSS <b>)n Cha</b> / <sub>GS(th)</sub> DS(on) <b>)ynami</b>	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
B <sub>VDSS</sub> DSS <b>GSS</b> <b>Dn Cha</b> V <sub>GS(th)</sub> DS(on) <b>D</b> S(on) <b>D</b> S(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charace Input Cap	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8 2.7 4.7	250 ±100 4 3.5	μA nA V mΩ
B <sub>VDSS</sub> DSS GSS Dn Cha /GS(th) DS(on) DS(on) Dynami Ciss Coss	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca	ource Breakdown V voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan cteristics	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T <sub>C</sub> = 15	0°C	- - - 2 -	2.8 2.7 4.7 9310	250 ±100 4 3.5	μΑ nA V mΩ
B <sub>VDSS</sub> DSS GSS Dn Cha V <sub>GS(th)</sub> DS(on)	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics pacitance apacitance Transfer Capacitance	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T <sub>C</sub> = 15 μΑ	0°C	- - - 2 -	2.8 2.7 4.7 9310 800	250 ±100 4 3.5	μA nA V mΩ pF pF
Byddss DSS GSS Dn Cha (GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics pacitance apacitance Transfer Capacitance	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T <sub>C</sub> = 15 μΑ	0°C		2.8 2.7 4.7 9310 800 510	250 ±100 4 3.5 6.1 - -	μA nA V mΩ pF pF
Byddss DSS DSS DSS DN Cha (GS(th) DS(on) DS(	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charae Input Cap Output Ca Reverse Gate Res Total Gate Threshold	ource Breakdown V Voltage Drain Curr burce Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance Transfer Capacitance istance e Charge at 10V I Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T <sub>C</sub> = 15 μA /, z V <sub>DD</sub> = 2			2.8 2.7 4.7 9310 800 510 0.9	250 ±100 4 3.5 6.1 - - - -	μA nA V mΩ pF pF pF
3vDSS DSS GSS Dn Cha /GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res Total Gate Threshold Gate to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance apacitance istance a Charge at 10V I Gate Charge ource Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T <sub>C</sub> = 15 μA /, z V <sub>DD</sub> = 20 I <sub>D</sub> = 35	0V - 5A		2.8 2.7 4.7 9310 800 510 0.9 142	250 ±100 4 3.5 6.1 - - - 185	μA nA V mΩ pF pF Ω nC
B <sub>VDSS</sub> DSS GSS Dn Cha (GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res Total Gate Threshold Gate to S	ource Breakdown V Voltage Drain Curr burce Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance Transfer Capacitance istance e Charge at 10V I Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T <sub>C</sub> = 15 μA /, z V <sub>DD</sub> = 2	0V - 5A	- - - - - - - - - - - - - -	2.8 2.7 4.7 9310 800 510 0.9 142 17.5	250 ±100 4 3.5 6.1 - - - 185 23	μΑ nA V mΩ pF pF pF Ω nC nC

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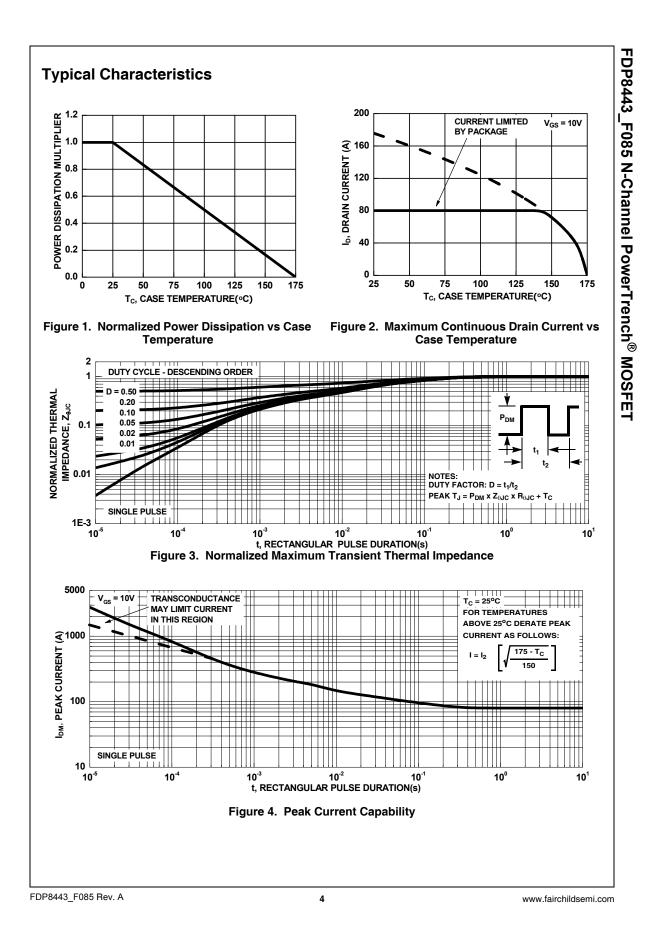
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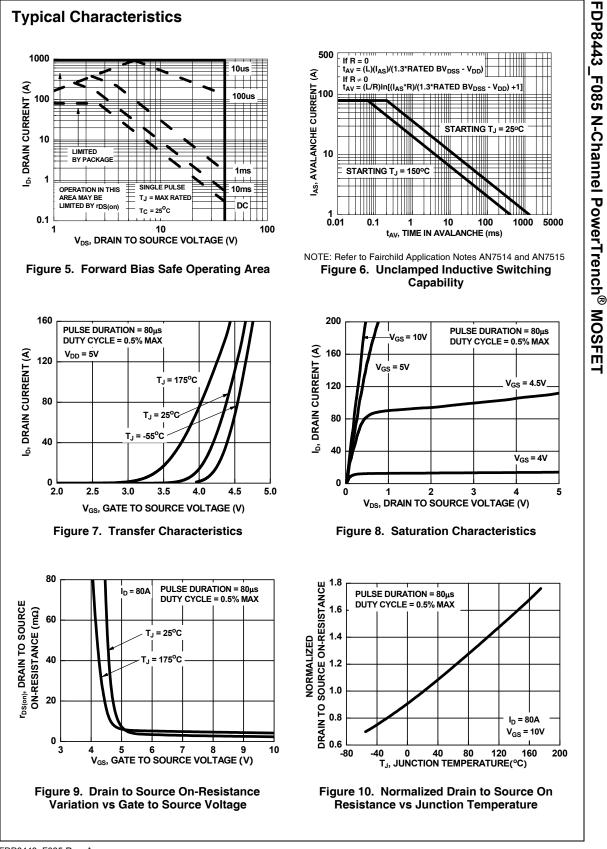
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Switch	ing Characteristics (V <sub>GS</sub>	= 10V)				
t <sub>on</sub>	Turn-On Time		-	-	58	ns
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD}$ = 20V, I <sub>D</sub> = 35A $V_{GS}$ = 10V, R <sub>GS</sub> = 2Ω	-	18.4	-	ns
t <sub>r</sub>	Rise Time		-	17.9	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	55	-	ns
t <sub>f</sub>	Fall Time		-	13.5	-	ns
t <sub>off</sub> Drain-So	Turn-Off Time Diode Characteristics		-	-	109	ns
Drain-So	ource Diode Characteristics	I <sub>SD</sub> = 35A	-	- 0.8	109	
				- 0.8 0.8		ns - V
Drain-So	ource Diode Characteristics	I <sub>SD</sub> = 35A	-		1.25	

This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at: http://www.aecouncil.com/ All Fairchild Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.



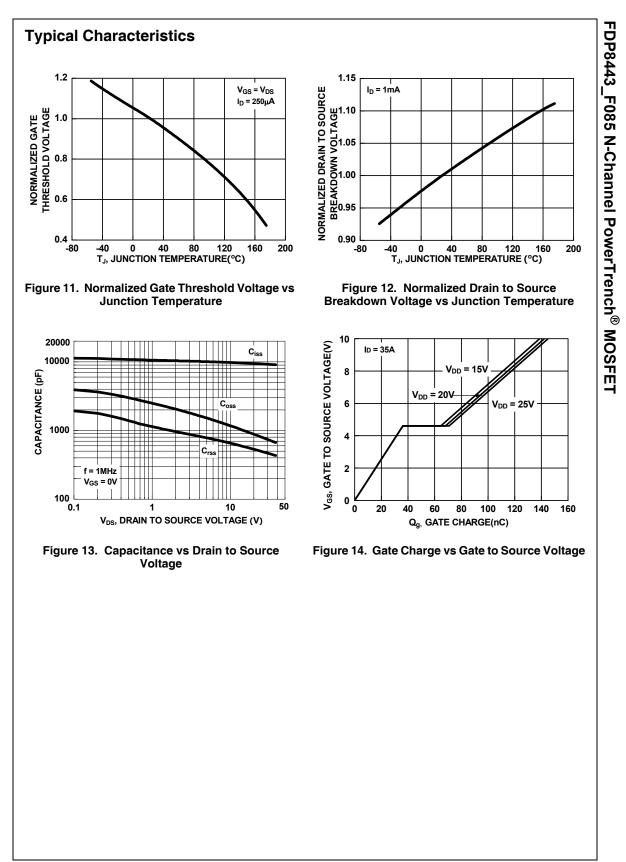






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